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AMENDMENT TRANSMETETATE ETTER (Large Entity) Applicant(s): Osamu ICHIKAWA					Docket No. L8462.04111	
Application No. 10/804,138	March 19, 2004	Examiner C. Britt	Customer N 52989	10.	Group Art Unit 2138	Confirmation No. 6381
Invention: SEMICONDUCTOR INTEGRATED CIRCUIT AND TEST METHOD THEREOF						
COMMISSIONER FOR PATENTS: Transmitted herewith is an amendment in the above-identified application. The fee has been calculated and is transmitted as shown below.						
CLAIMS AS AMENDED						
	CLAIMS REMAINING AFTER AMENDMENT	HIGHEST #	NUMBER EXTRA		RATE	ADDITIONAL FEE
TOTAL CLAIMS	27 -	27 =	0	х	\$50.00	\$0.00
INDEP. CLAIMS	5 -	5 =	0	х	\$200.00	\$0.00
Multiple Dependen	nt Claims (check if appl	licable)				\$0.00
		TOTAL ADDITIONAL F	FEE FOR THIS AMI	END	DMENT	\$0.00
No additional fee is required for amendment. ☐ Please charge Deposit Account No. in the amount of ☐ A check in the amount of to cover the filing fee is enclosed. ☐ The Director is hereby authorized to charge payment of the following fees associated with this communication or credit any overpayment to Deposit Account 19-4375 ☐ Any additional filing fees required under 37 C.F.R. 1.16. ☐ Any patent application processing fees under 37 CFR 1.17. ☐ Payment by credit card. Form PTO-2038. WARNING: Information on this form may become public. Credit card information should not be included on this form. Provide credit card information and authorization on PTO-2038. Dated: June 20, 2006						
James E. Ledbette Registration No. 2 Stevens, Davis, Mi 1615 L Street, N.V Washington, DC 2 Tel: 202-785-0100 Fax: 202-408-5200		I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to "Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450" [37 CFR 1.8(a)] on				
			Signature of Person Mailing Correspondence			
cc:			Typed or Printed Name of Person Mailing Correspondence			

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Inventor:

Osamu ICHIKAWA

Group Art Unit: 2138

Appln. No.:

10/804,138

Examiner: C. Britt

Filed:

March 19, 2004

For:

SEMICONDUCTOR INTEGRATED CIRCUIT AND TEST METHOD

THEREOF

AMENDMENT UNDER 37 CFR \$1.111 AND SUMMARY OF SUBSTANCE OF TELEPHONE INTERVIEW

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In response to the Office Action dated April 7, 2006, please amend the above-captioned application as follows: